Quantum oscillations of transport coefficients and capacitance: an unexpected manifestation of the spin-Hall effect

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The results of systematic experimental studies of quantum oscillations of resistivity, Hall coefficient and capacitance in GaAs and $In_x Ga_{1-x} As$ quantum wells (QWs) with a simple electron spectrum and HgTe QWs with a complicated non-parabolic spectrum and strong spin-orbit interaction are reported. A striking result is the ratio of the amplitudes of the resistance and Hall coefficient oscillations. In GaAs QW with a simple spectrum characterized by negligibly small Zeeman and spin-orbit splitting, the ratio of amplitudes is close to that predicted theoretically. In HgTe OWs, this ratio is very different and behaves differently in QWs with normal and inverted electron spectra. In HgTe WQs with a normal spectrum, it tends to a theoretical value with an increase of the filling factor (N), while for HgTe QWs with an inverted spectrum, it differs significantly from the theoretical one for all available N. It is assumed that such a difference in the ratio of amplitudes in GaAs and HgTe QWs is due not to the peculiarities of the energy spectrum of HgTe, but to the peculiarities of electron scattering due to spin-orbit interaction with the potential of the scatterers. This assumption is justified by analysis of experimental results obtained for a heterostructure with a In_{0.2}Ga_{0.8}As QW, which spectrum is very close to the GaAs QW spectrum, but characterizes by much stronger spin-orbit splitting value. It has been found that the positions of the resistance and capacitance oscillations, the difference between the phases of the resistance and Hall coefficient oscillations and its N dependence are close to those observed in GaAs QW. At the same time the ratio of the amplitude of the resistance oscillations to the Hall coefficient oscillations and its Ndependence differs very strongly and they are close to that observed in HgTe quantum wells.

I. INTRODUCTION

The study of Shubnikov-de Haas (SdH) oscillations is one of the most common and powerful methods for studying the energy spectrum, carrier scattering mechanisms in semiconductors, metals and semimetals. The possibilities of this method are significantly expanded when studying two-dimensional (2D) systems, since the gate electrode allows us to change the carrier density (n), and hence the Fermi energy (ε_F) in a wide range.

The SdH oscillations result from the quantization of the energy spectrum by the magnetic field (B) that leads to oscillations of the density of states (ν) at a fixed energy as a function of the magnetic field, and/or to oscillations of the density of states with energy at a fixed magnetic field. Oscillations in the density of states lead to oscillations in the momentum relaxation time τ_B .

Theoretically, the SdH oscillations have been considered in many papers [1–5]. As a rule, the components of the conductivity tensor σ were calculated in them. Established expressions σ_{xx} and σ_{xy} [6] are:

$$\sigma_{xx} = e^2 v_F^2 \int d\varepsilon \left(-\frac{\partial f_\varepsilon^T}{\partial \varepsilon} \right) \frac{\nu(\varepsilon) \tau_B(\varepsilon)}{1 + \omega_c^2 \tau_B^2} \tag{1}$$

$$\sigma_{xy} = -\frac{en}{B} + \frac{e^2 v_F^2}{\omega_c} \int d\varepsilon \left(-\frac{\partial f_\varepsilon^T}{\partial \varepsilon}\right) \frac{\nu(\varepsilon)}{1 + \omega_c^2 \tau_B^2}, \quad (2)$$

where e is the elementary charge, f_{ε}^{T} is the thermal distribution function, $\omega_{c} = eB/m_{e}, \nu(\varepsilon) = \nu_{0}(1+\Delta\nu(\varepsilon)/\nu_{0})$

is the density of states with ν_0 as the density of states at B = 0, and $\Delta \nu(\varepsilon)$ as the oscillating part of the density of states, v_F is the carrier velocity at the Fermi level. Expressions (1) and (2) can be written in a simpler form if $\varepsilon_F \gg k_B T$:

$$\sigma_{xx}(B,\varepsilon_F) = \frac{e^2 v_F^2 \tau_B(B,\varepsilon_F) \nu(B,\varepsilon_F)}{1 + \omega_c^2(B) \tau_B^2(B,\varepsilon_F)}$$
(3)

$$\sigma_{xy} = -\frac{en}{B} + \frac{e^2 v_F^2}{\omega_c(B)} \frac{\nu(B,\varepsilon_F)}{1 + \omega_c^2(B)\tau_B^2(B,\varepsilon_F)}.$$
 (4)

The result is that the theory for the first subband of spatial quantization can be formulated solely in terms of the oscillating $\Delta \nu$ and the transport scattering rate $1/\tau(B)$ which is renormalized by Landau quantization. The renormalization of the density of states $\nu(B, \varepsilon_F)$ and the relaxation time $\tau_B(B, \varepsilon_F)$ in a magnetic field are related as $1/\tau_B(B, \varepsilon_F) = 1/\tau \times \nu(B, \varepsilon_F)/\nu_0$ [6], where τ is the transport relaxation time in zero magnetic field. Considering this, we get for σ_{xx}

$$\sigma_{xx}(B,\varepsilon_F) = \frac{e^2 v_F^2 \tau \nu_0}{1 + \omega_c^2(B) \tau_B^2(B,\varepsilon_F)} \tag{5}$$

As a rule, the components of the resistance tensor ρ are measured experimentally, which are related to the σ components by simple relations $\rho_{xx} = \sigma_{xx}/(\sigma_{xx}^2 + \sigma_{xy}^2)$ and $\rho_{xx} = \sigma_{xy}/(\sigma_{xx}^2 + \sigma_{xy}^2)$. Expanding Eqs. (4) and (5) in terms of the smallness of the amplitude of oscillations of the density of states $\Delta \nu / \nu_0$, one obtains

$$\rho_{xx} = \rho_0 \left(1 + 2\frac{\Delta\nu}{\nu_0} \right), \tag{6}$$

$$\rho_{xy} = \frac{B}{en} \left(1 - \frac{1}{\mu^2 B^2} \frac{\Delta \nu}{\nu_0} \right). \tag{7}$$

Here $\mu = e\tau/m$ is the mobility, $\rho_0 = 1/(en\mu)$. Oscillating parts of ρ_{xx} and $R_H = -\rho_{xy}/B$, defined as $\delta\rho_{xx} = \rho_{xx}/\rho_0 - 1$ and $\delta R_H = R_H/R_0 - 1$, where $R_0 = -1/en$, have the form

$$\delta \rho_{xx} = 2 \frac{\Delta \nu}{\nu_0} \mathcal{F} \left(\frac{2\pi^2 k_B T}{\hbar \omega_c} \right), \tag{8}$$

$$\delta R_H = -\frac{1}{(\mu B)^2} \frac{\Delta \nu}{\nu_0} \mathcal{F}\left(\frac{2\pi^2 k_B T}{\hbar \omega_c}\right),\tag{9}$$

where the factor $\mathcal{F}(x) = x/\sinh(x)$ describes the thermal averaging of the oscillations,

$$\frac{\Delta\nu}{\nu_0} = -2\exp\left(-\frac{\pi}{\omega_c\tau_q}\right)\cos\left(\frac{2\pi\varepsilon_F}{\hbar\omega_c}\right) \tag{10}$$

for the case when the Fermi level is kept constant in the magnetic field, and

$$\frac{\Delta\nu}{\nu_0} = -2\exp\left(-\frac{\pi}{\omega_c\tau_q}\right)\cos\left(\frac{2\pi^2\hbar n}{eB}\right),\qquad(11)$$

when the electron density is constant, therewith the Landau levels are twofold degenerate. Here, τ_q is the quantum relaxation time. Since $n = \text{const}_B$ in the structures under study (see Section III) we will use Eq. (11) so that

$$\delta \rho_{xx} = -4 \exp\left(-\frac{\pi}{\omega_c \tau_q}\right) \cos\left(\frac{2\pi^2 \hbar n}{eB}\right) \mathcal{F}\left(\frac{2\pi^2 k_B T}{\hbar \omega_c}\right).$$
(12)

It follows From Eqs. (8) and (9) that the oscillations of ρ_{xx} and R_H should be in antiphase, and the ratio of the oscillation amplitudes ρ_{xx} and R_H (denoted as A_{ρ} and A_H , respectively) should be equal to

$$\frac{A_{\rho}}{A_H} = -2\mu^2 B^2. \tag{13}$$

The approximations made in obtaining the equations from (6) to (13) are discussed in detail in Ref. [6]. They are as follows:

- 1. The equations are valid in low magnetic fields as long as $\delta \rho_{xx} \ll 1$, i.e., before the onset of the quantum Hall effect (QHE) regime;
- 2. There is neither Zeeman nor spin-orbital (SO) splitting of Landau levels in the actual magnetic field range;
- 3. It is assumed that there is only a homogeneous broadening of the Landau levels, which leads to a Lorentzian shape of the density of states with a width Δ_L . That is, large-scale fluctuations, which lead to a Gaussian shape of the density of states with a width Δ_G , are neglected.

Note that the mobility μ in Eq. (13) includes the transport relaxation time, whereas the width of the Landau levels is determined by the quantum relaxation time. These times coincide only in the case of a short-range scattering potential when the Gaussian broadening is absent.

Eqs. (8) and (9) are very simple, but a lot follows from them, namely:

- 1. Oscillations are periodic in the reciprocal magnetic field;
- 2. The period of oscillations in the reciprocal magnetic field is determined by the carrier density and the degeneracy of the states;
- 3. Comparison of this density with the Hall density $n_H = 1/(e|R_H|)$ makes it possible to determine the degeneracy of the Landau levels;
- 4. Predicted dependence of the oscillation amplitude on temperature and magnetic field makes it possible to determine the effective mass of carriers the broadening of the Landau levels;
- 5. The positions of the oscillations of $\rho_{xx}(B)$ should coincide with the positions of the oscillations of the density of states.
- 6. The $\delta \rho_{xx}$ and δR_H oscillations should be antiphase;
- 7. Ratio of oscillation amplitudes of $\delta \rho_{xx}$ and δR_H and their dependences on the magnetic field should satisfy Eq. (13);
- 8. Extrapolating the positions of the oscillation minima plotted in the ρ_{xx} vs 1/B coordinates to B = 0allows one to determine the Berry phase[7].

Experimentally, the SdH oscillations have been studied in a very wide range of 2D systems. The discrepancy between the experimental and predicted value of the phase difference of the ρ_{xx} and R_H oscillations, found in many papers, poses a simple question not answered up to now: the phase of which oscillations, ρ_{xx} or R_H , differs from that predicted theoretically? There is no experimental answer to it. As mentioned above the positions of the oscillations of $\rho_{xx}(B)$ should coincide with the positions of the oscillations of the density of states ν . On the other hand, the oscillations of ν directly determine the oscillations of capacitance (C) between the two-dimensional electron gas and the gate electrode. Hence a comparison of the oscillations of $\rho_{xx}(B)$ with those of C(B) can give an unambiguous answer to this question.

The relationship between the amplitudes of ρ_{xx} and R_H oscillations and their magnetic field dependences, as far as we know, was studied only in [8] for electrons in GaAs quantum well (QW) with the simplest spectrum, small Zeeman and SO splitting.

In this paper we present the results of the experimental investigations of the oscillations of the resistivity, Hall coefficient, and capacitance between the gate electrode and quantum well in GaAs and $\ln_x \text{Ga}_{1-x}$ As QWs with a simple spectrum of the conduction band and in HgTe QWs with a complicated non-parabolic spectrum and strong SO interaction.

The paper is organized as follows. The samples and experimental conditions are described in the next section. The experimental results and their analysis concerning the phase of the oscillations of ρ_{xx} , C, and R_H for the GaAs and HgTe QWs are presented in Secs. III and IV. Section V is devoted to the analysis of the magnetic field dependences of the ratio of the amplitudes of the quantum oscillations of ρ_{xx} and R_H . The discussion is given in Section VI. Also in this section, the results obtained for the $\ln_x Ga_{1-x}As$ QW are presented to elucidate the role of the physical mechanisms responsible for the effects considered in the previous sections. The conclusions are in Sec. VII.

II. EXPERIMENTAL

Our samples with the HgTe quantum wells were realized on the basis of HgTe/Hg_{1-x}Cd_xTe (x = 0.39 - 0.6) heterostructures grown by the molecular beam epitaxy on a GaAs substrate [9].

The quantum well GaAs/In_{0.2}Ga_{0.8}As/GaAs heterostructure were grown by metal-organic vapor phase epitaxy on semi-insulator GaAs substrate. The heterostructure consists of 0.5 mkm-thick undoped GaAs epilayer, a Sn δ -layer, a 12 nm spacer of undoped GaAs, a 8 nm In_{0.2}Ga_{0.8}As well, a 12 nm spacer of undoped GaAs, a Sn δ -layer, and a 300 nm cap layer of undoped GaAs.

The Al_xGa_{1-x}As/GaAs/Al_xGa_{1-x}As heterostructure was grown by molecular beam epitaxy. It consists of 250 nm-thick undoped GaAs buffer layer grown on semiinsulator GaAs, a 50 nm Al_{0.3}Ga_{0.7}As barrier, Si δ -layer, a 6 nm spacer of undoped Al_{0.3}Ga_{0.7}As, a 8 nm GaAs well, a 6 nm spacer of undoped Al_{0.3}Ga_{0.7}As, a 8 i δ -layer, a 50 nm Al_{0.3}Ga_{0.7}As barrier, and 200 nm cap layer of undoped GaAs.

The samples were mesa etched into standard Hall bars of 0.5-mm width with the distance between the potential probes of 0.5 mm. To change and control the carrier density in the quantum well, the field-effect transistors were fabricated with parylene as an insulator and aluminium as a gate electrode. For each heterostructure, several samples were fabricated and studied. All measurements were carried out using the dc technique in the linear response regime at T = (1.3...10.0) K within the magnetic field range up to 2.5 T.

The parameters of the structures under study are presented in the Table I.



FIG. 1. (color online) Magnetic field dependences of $\delta \rho_{xx}$, δR_H and of the oscillating part of the capacitance δC at $V_g = 0$, T = 3.9 K. The left inset shows the gate voltage dependences of the Hall density $n = 1/e|R_H(1 \text{ T})|$ and the electron density determined from the period of SdH oscillations under the assumption of twofold degeneracy of the Landau levels. The line is the dependence $n = (14.9 + 2.0 V_g) \times 10^{11} \text{ cm}^{-2}$. The right inset is the gate voltage dependences of the mobility determined as $\mu = |R_H(1 \text{ T})|/\rho_{xx}(1 \text{ T})$. The structure T1520 with GaAs QW.

B (T)

III. PHASE OF OSCILLATIONS OF $\rho_{xx}(B)$ AND C(B)

Let us try to answer the simplest question formulated in the introduction: does the phase of oscillations of $\rho_{xx}(B)$ coincide with the phase of oscillations of the density of states?

First we consider the results of oscillation measurements for a structure T1520 with GaAs QW with the simplest spectrum, in which the Zeeman and SO splitting is negligibly small in the used range of magnetic fields, temperatures, and electron density. For a general characterization of the structure, let us inspect the insets of Fig. 1.

The left inset in Fig. 1 shows that the electron densities found from the Hall effect and from the oscillation period under the assumption of a twofold degeneracy of Landau levels coincide. The electron density changes linearly with V_g with a rate of 2.0×10^{11} cm⁻²V⁻¹. This value, within the experimental error, coincides with dn/dV_g determined from the capacitance value. These results show that there are no additional states in the barriers near the Fermi level in this range of electron density, which also implies that the electron density remains constant when the magnetic field changes.

Fig. 1 shows the oscillating parts of $\rho_{xx}(B)$, $R_H(B)$ (obtained as $\delta \rho_{xx} = \rho_{xx}/\rho_{xx}^{mon} - 1$, $\delta R_H = R_H/R_H^{mon} - 1$, where, ρ_{xx}^{mon} and R_H^{mon} are the monotonic parts of the magnetic field dependences of ρ_{xx} and R_H , respectively) [10], and oscillating part of C(B) measured on the same structure under the same conditions for $n \simeq 1.5 \times$

#	QW	d (nm)	type	$n(\mathrm{cm}^{-2})^{\mathrm{a}}$	$\mu \ (m^2/Vs)^a$	
T1520	GaAs	8.0	n	1.56×10^{12}	1.9	
170928	HgTe	5.1	n	4.32×10^{11}	2.9	
H1023	HgTe	6.5	n	1.60×10^{11}	9.5	
HT71	HgTe	9.5	n	$0.93 imes 10^{11}$	6.3	
180824	HgTe	32	p	_	_	
Z76	$\mathrm{In}_{0.2}\mathrm{Ga}_{0.8}\mathrm{As}$	8.0	n	6.25×10^{11}	2.5	

TABLE I. The parameters of heterostructures under study

^a For $V_g = 0$ V

 10^{12} cm⁻². As seen the phase of $\delta \rho_{xx}(B)$ differs from the phase of $\delta R_H(B)$, but this difference is not equal to π . The main thing clearly seen from this figure is that the positions of the oscillations of $\delta \rho_{xx}(B)$ and $\delta C(B)$ coincide. Since the C(B) oscillations are directly determined by the oscillations of the density of states at the Fermi level it follows from this that the oscillations $\rho_{xx}(B)$ are also determined by the oscillations of the density of states at the Fermi level only. The same ratio of the positions of the C(B) and $\rho_{xx}(B)$ oscillations is also observed at lower densities, and, despite the fact that the amplitude of the oscillations becomes much smaller, the mutual positions of the extrema of C(B) and $\rho_{xx}(B)$ remain the same.

Let us now consider the results obtained for structures with HgTe QWs which spectrum changes very strongly with increasing QW width from the normal at d < 6.3 nm to inverted at d > 6.3 nm and semimetallic at $d \gtrsim 15$ nm [11]

We start by considering the results for the structure 170928 with a HgTe QW of 5.1 nm wide with a normal spectrum (Fig. 2). As in GaAs QWs, the electron density found from the Hall effect and SdH oscillations coincide, varying linearly with V_g [left inset in Fig. 2(a)]. It is seen that the phase of $\delta \rho_{xx}(B)$ differs from the phase of $\delta R_H(B)$, but this difference is not equal to π . Like GaAs QW, the positions of the oscillations of $\delta \rho_{xx}(B)$ and $\delta C(B)$ coincide for both electron densities.

The same phase coincidence of the $\rho_{xx}(B)$ and C(B) oscillations is observed for the structure HT71 with HgTe QW with the inverted spectrum, d = 9.5 nm (Fig. 3).

Above we considered the results for HgTe QWs, in which SO interaction did not lead to spectrum splitting in the actual gate-voltage range. In what follows we present the results obtained for the structure 180824 with a 32 nm wide HgTe QW, in which, as the gate voltage increases, a large splitting of the conduction band spectrum occurs due to the spin–orbit interaction of the Rashba type. As seen from Fig. 4, the Fourier spectrum of ρ_{xx} oscillations splits into two components of the frequencies f_1 and f_2 at $V_g > 1.5$ V, when the electron density is higher than 1.7×10^{11} cm⁻², and the splitting value increases with increasing V_g . In this case, the sum of densities found from two harmonics, $n(f_1)$, $n(f_2)$, assuming that they are single-spin, is equal to the to-



FIG. 2. (color online) Magnetic field dependences of $\delta \rho_{xx}$, δR_H , and of the oscillating part of the capacitance δC for the structure 170928 with HgTe QW with d = 5.1 nm for electron density 4.35×10^{11} cm⁻² (a) and 6.59×10^{11} cm⁻² (b). The left inset in (a) shows the gate voltage dependences of the Hall density and the electron density determined from the period of SdH oscillations under the assumption of twofold degeneracy of the Landau levels. The line is the dependence $n = (4.25 + 1.1 V_g) \times 10^{11}$ cm⁻². The right inset is the gate voltage dependences of the mobility. T = 4.5 K.

tal density determined from the Hall effect [Fig. 4(a)]. Thus, at $n > 1.7 \times 10^{11}$ cm⁻², two single-spin branches are formed in the spectrum of the conduction band.

Let us now consider the results obtained at $V_g = 1.5$ V, at which QW is close to symmetric, there is no splitting of the oscillations, and they correspond to doubly degenerate Landau levels. This follows from the fact that the electron density found from the oscillation period, under the assumption of twofold degeneracy of the Landau levels, coincides with the Hall electron density within experimental accuracy. Oscillations $\delta \rho_{xx}(B)$, $\delta R_H(B)$ and $\delta C(B)$ are shown in Fig. 5(a). It is seen that the positions of the $\delta \rho_{xx}(B)$ and $\delta C(B)$ oscillations, as in the previously considered structures, coincide within experimental accuracy, and the amplitude of the $\delta \rho_{xx}$ oscillations is also approximately an order of magnitude greater than the amplitude of $\delta R_H(B)$.



FIG. 3. (color online) Magnetic field dependences of $\delta \rho_{xx}$, δR_H , and δC for the structure HT71 with HgTe QW, d = 9.5 nm for $n = 2.03 \times 10^{11}$ cm⁻². The left inset in (a) shows the gate voltage dependences of the Hall density and the electron density determined from the period of SdH oscillations under the assumption of twofold degeneracy of the Landau levels. The line in the left inset is the dependence $n = (0.95 + 0.51 V_g) \times 10^{11}$ cm⁻². The right inset is the gate voltage dependences of the mobility.



FIG. 4. (color online) (a) The gate voltage dependence of the electron density for the structure 180824 with d = 32 nm: n_H is the Hall density $n_H = 1/eR_H(0.2 \text{ T})$; $n(f_1)$ and $n(f_2)$ are the densities corresponding to the frequencies f_1 and f_2 [see the panel (c)] considering them come from single-spin Landau levels; lines are the result of the liner fit. T = 4.2 K. (b) Oscillations of $\delta \rho_{xx}$ for some V_g values; (c) The Fourier spectra of the oscillations shown in Fig. 4(b) in the *B* range from 0.2 to 0.6 T. The upper limit of B=0.6 T is determined by the onset of QHE. The dotted line in (c) follow the peak corresponding to the magneto-intersubband oscillations [12] not discussed in this paper.



FIG. 5. (color online) Oscillating parts of ρ_{xx} , R_H , and C plotted against the magnetic field for the structure 180824 with HgTe QW, d = 32 nm for $V_g = 1.5$ V (a) and $V_g = 3.0$ V (b). In Fig. 5(b), the upper group of the curves is the experimental dependences, the middle and lower groups are the results of the inverse Fourier transformation, which correspond to the two branches of the spectrum split by SO interaction. T = 4.2 K.

Let us now consider the same dependences obtained for the case of a large SO splitting [Fig. 5(b)]. The oscillation beats clearly evident in three upper curves in Fig. 5(b) is manifestation of splitting of the energy spectrum of the conduction band due to the SO interaction. To separate the contributions of each of the split components, the Fourier transformation technique is used (for more details, see Ref. [13]). The results are the two lower triplets of curves in Fig. 5(b). As seen the positions of the capacitance oscillations for each of the branches of the spectrum still practically coincide with the positions of the oscillations $\delta \rho_{xx}(B)$. Therewith the phase shifts of the oscillations $\delta \rho_{xx}(B)$ and $\delta R_H(B)$ are approximately the same for both branches of the spectrum and approximately the same as for all the cases considered above.

Thus, the above results of studies of GaAs QWs with a simple spectrum, small Zeeman and SO interactions, and HgTe QWs with a normal, inverted, and semimetal spectrum show that the positions of the oscillations $\delta \rho_{xx}(B)$ and $\delta C(B)$ in the magnetic field match. Since the oscillations of the density of states, the oscillations $\delta \rho_{xx}(B)$ are also determined by the oscillations of the density of states.

IV. PHASES OF THE QUANTUM OSCILLATIONS OF $\rho_{xx}(B)$ AND $R_H(B)$

Let us now determine the values of the oscillation phases in $\delta \rho_{xx}(B)$ and $\delta R_H(B)$ denoted as φ_N^{ρ} and φ_N^H , respectively. As shown above for this structure (as well as for all the structures investigated in this paper) $n = \text{const}_B$. In this case, the ρ_{xx} oscillation phase is easy



FIG. 6. (color online) The N dependences of phases of ρ_{xx} and R_H oscillations, φ_N^{ρ} and φ_N^H , respectively, for the structure T1520 with GaAs QW for two electron density values for T = 1.5 K and 4.5 K.

to determine. Indeed, the magnetic fields B_N^{ρ} at which the minima $\rho_{xx}(B)$ are observed correspond to minima in the density of states, and they occur when the Fermi level is in the middle between the two nearest Landau levels (this does not depend on the ratio between $\hbar\omega_c$ and the broadening of the Landau levels). Hence, with taking into account the degeneracy of each Landau level in the absence of Zeeman splitting equal to $eB/(\pi\hbar)$ one obtain that the minima of $\delta\rho_{xx}(B)$ should be observed at $B_N^{\rho} = 2\pi\hbar n/(eN)$, i.e., the phase of the oscillations φ_N^{ρ} must be equal to zero. The minima of $R_H(B)$ should be observed at $B_N^H = 2\pi\hbar n/[e(N + \varphi_N^H)]$.

As in the previous section, let us first consider the results for GaAs QW. The N dependences of φ_N^{ρ} and φ_N^H found in this way for two electron densities are shown in Fig. 6. It is seen that the oscillation phase of $\delta \rho_{xx}(B)$ is equal to zero within experimental uncertainty over the entire range of filling factors. The oscillation phase of $\delta R_H(B)$ is close to 0.5 cycles (or π radians) for large filling factors, N > 15 - 17, and increases up to 0.7 ± 0.1 for N = 5.

Similar dependences of the oscillation phases φ_N^{ρ} and φ_N^H were obtained in GaAs QWs in Ref. [8]. An increase in the oscillation phase φ_N^H with decreasing $1/B_N$ was associated with approaching QHE regime. The role of this mechanism can be assessed experimentally. Indeed, in this case, as the temperature decreases, the deviation φ_N^H from 0.5 should increase and begin at larger N. However, in our case, as Fig. 6 shows, such behaviour is not observed. In addition, in our range of magnetic fields, the oscillation amplitude of ρ_{xx} is less than 5 %, so this mechanism seems unlikely.

We turn now to results obtained for HgTe QWs. The results of the measurements of the oscillation phases for HgTe QW with the normal spectrum are shown in Fig. 7(a). It is seen that all the main features are close to that for GaAs QW, namely: (i) the phase of ρ_{xx} oscil-



FIG. 7. (color online) The N dependences of phases of oscillations of ρ_{xx} and R_H for the structures 170928 and HT71 with HgTe QWs of 5.1 nm (a) and 9.5 nm (b) widths for several electron density.

lations is close to zero; (ii) the R_H oscillation phase somewhat decreases with increasing N, but remains above the theoretical value of 0.5. Similar N dependences of the oscillation phases of ρ_{xx} and R_H are also observed in structures with HgTe QW with an inverted spectrum, d = 9.5 nm [see Fig. 7(b)]. As for the structure 180824 with d = 32 nm, it is impossible unfortunately to determine the oscillation phases by the method used above. This is due to the fact that only the total electron density, i.e., the sum of the electron densities in the split branches, is constant in the magnetic field, whereas the density in each of the branches separately oscillate.

Thus, analyzing the data for GaAs and HgTe QWs in Sections III and IV we show that: (i) the oscillations of $\rho_{xx}(B)$ are entirely determined by the oscillations of the density of states; (ii) the oscillation phase of $\rho_{xx}(B)$ over the entire range of N is close to zero, which corresponds to the theory, while the oscillation phase of $R_H(B)$ is close to the theoretical value of 0.5 cycles only for large N values and increases as they decrease; (iii) Such the increase is not associated with approaching the QHE regime; (iv) Physical reason for the growth of oscillation phase of $\delta R_H(B)$ observed in many papers [8, 14– 16] remains unclear.

V. AMPLITUDES OF THE QUANTUM OSCILLATIONS OF $\rho_{xx}(B)$ AND $R_H(B)$

As discussed in Section I, the theory predicts a simple ratio of the oscillation amplitudes $\delta \rho_{xx}$ and δR_H , Eq. (13). Let us compare the experimental values of

$$R = -2(\mu B)^2 A_H / A_\mu$$

with the theoretical values for the structures considered above.

As in Sections III and IV, we first consider the results of measurements for GaAs QW with a simple spectrum,



FIG. 8. (color online) The R value plotted as function of the filling factor (a) and reciprocal magnetic field (b) for the structure T1520 with GaAs QW for three electron density values, T = 1.4 K.

in which the Zeeman and spin-orbit splitting is negligibly small in the actual range of magnetic fields, and electron densities.

The N dependences of R plotted in Fig. 8 for three electron densities show that the R value is close to unity for filling factors N > 13-14 in accordance with Eq. (13). As N decreases, the ratio slightly increases. Note that ratio deviates from theory at about the same N as the dependence $\varphi_N^H(N)$ deviates from 0.5 (see Fig. 6). This result also agrees with the results from Ref. [8]. Note, the R vs N dependences obtained for different electron densities lie on the same curve, while the R vs 1/B dependences do not.

Let us now consider the R versus N dependence for HgTe QW. First, as in the previous section, we consider the results for the structures 170928 with a normal spectrum, d = 5.1 nm (Fig. 9). It is seen that they are qualitatively similar to those for GaAs QW (Fig. 8); the R vs N dependences obtained for different n lie on the common curve, while the R vs 1/B dependences differ significantly. Along with this there is a quantitative difference with GaAs QW. As seen from Fig. 9(b) the R value being close to unity at N > 11 - 12 increases very strongly with decreasing N and becomes three times larger than that in GaAs QW at N = 6 [see Fig. 8(b)].

We now inspect the results for the structure H1023 with an inverted spectrum with d = 6.5 nm that is a little more than $d_c = 6.3$ nm[17]. Fig. 10 shows that the R vs N and R vs 1/B dependences differ significantly from these observed in the structure with a normal spectrum shown in Fig. 9. The R value reaches 24 at N = 6. With increasing N, the ratio decreases to a value of 6-8, which is much larger than the theoretical value equal to unity. The N dependence as well as the 1/B dependence of the ratio found for different electron densities do not fall on the one curve.



FIG. 9. (color online) The R values plotted against the filling factor (a) and reciprocal magnetic field (b) for the structure 170938 with HgTe QW of 5.1 nm width with normal spectrum for different electron densities. T = 3.7 K.



FIG. 10. (color online) The R values plotted against the filling factor (a) and reciprocal magnetic field (b) for the structure H1023 with HgTe QW with inverted spectrum, d = 6.5 nm, for different electron densities. T = 3.7 K.

Finally, let us consider the results for a structure HT71 with d = 9.5 nm which is significantly larger than d_c . Fig. 11 shows that in this case the ratio is even larger than that in the structure H1023 with d = 6.5 nm for all available filling factors. In contrast to the structure 170928 with a normal spectrum, in this case, the ratio plotted as function of 1/B for different electron densities falls on one curve, whereas the R values plotted as function of N does not.

Thus, in contrast to the phases of the ρ_{xx} and R_H oscillations, whose dependences on the filling factor are practically the same in GaAs and HgTe quantum wells both with normal and inverted spectra, the dependences of the ratio of amplitude of the oscillation of $\rho_{xx}(B)$ and $R_H(B)$ on the filling factor and on reciprocal magnetic field differ greatly. In GaAs QWs, the ratio for large N



FIG. 11. (color online) The R values plotted against the filling factor (a) and reciprocal magnetic field (b) for the structure HT71 with HgTe QW with inverted spectrum, d = 9.5 nm, for different electron densities. T = 3.7 K.

is close to unity, as predicted by the theory and increases somewhat with decreasing N. In HgTe QWs, the ratio increases strongly with decreasing N and differently in structures with normal and inverted spectra. In the narrowest QW the R versus N dependences lie on the same curve for the different electron density, while in the widest QW the dependences the R versus 1/B lie on the same curve.

VI. DISCUSSION

Let us discussed the differences between GaAs and HgTe QWs, which could be responsible for the different behaviour of the effects considered in the previous Sections.

The obvious difference is the nonparabolicity of the energy spectrum. In GaAs QWs, the nonparabolicity is very low in the actual range of electron densities, while in HgTe QWs it is much stronger. But for large N, the position of the Landau levels in the magnetic field at a fixed electron density or the Fermi energy does not depend on the nonparabolicity of the energy spectrum.

The other difference is the strength of SO interaction of the Rashba type. In GaAs QWs, the SO interaction is weak. It is much stronger in HgTe QWs. When the SO interaction is less than the broadening of the Landau levels and $\hbar\omega_c$ within actual magnetic field range, the positions of the maxima of the density of states is the same as in the absence of SO splitting. But in this case, the SO interaction can change the scattering due to the SO interaction with the potential of the scatterers. We are not aware of any theoretical papers in which the effect of this interaction on the amplitudes of $\delta\rho_{xx}$ and δR_H oscillations was considered.

Luckily, the role of this interaction can be tested experimentally by comparing the amplitudes of the $\delta \rho_{xx}$ and δR_H oscillations in structures with a close energy



FIG. 12. (color online) The antilocalization magnetoconductivity in the structure Z76 with the In_{0.2}Ga_{0.8}As QW for $n = 6.5 \times 10^{11}$ cm⁻², $\mu = 2.58$ m²/Vs. The symbols are the data, the curve is the result of the best fit with the phase and spin relaxation times equal to 1.04×10^{-10} s and 3.6×10^{-11} s, respectively (for more details, see Ref. [18]). T = 0.47 K.

spectrum, but with different Rashba parameters. In our case, these are GaAs and $In_xGa_{1-x}As$ QWs. In the $In_xGa_{1-x}As$ QWs, the Rashba parameter is much larger than that in GaAs QWs, whereas the other parameters of the spectrum are close for both types of the QWs if the indium concentration x is relatively small. So, for x = 0.2 they are only (10 - 15)% smaller than that in GaAs QWs (see Table II).

Although the SO interaction in $In_{0.2}Ga_{0.8}As$ QWs is stronger than that un GaAs QWs, it is relatively weak to manifest itself in the SdH oscillations and in their Fourier spectrum. In this case the presence and the value of the SO splitting can be estimated from the magnetic-field behaviour of the weak localization correction to the conductivity. As known the SO interaction leads to antilocalization behaviour of the magnetoresistance in low magnetic fields. The dependence $\Delta\sigma(B) = \rho_{xx}^{-1}(B) - \rho_{xx}^{-1}(0)$ for the heterostructure Z76 with the $In_{0.2}Ga_{0.8}As$ QW shown in Fig. 12 demonstrates clearly the antilocalization behaviour in low fields. The processing of these results similar to that used in [18] gives the value of the SO splitting of about (0.10 - 0.15) meV.

As for the structure T1520, only weak localization behaviour has been observed. This means that the value of the SO splitting in the GaAs QW is much smaller than that in $In_{0.2}Ga_{0.8}As$ QW.

Thus the only factor that differs significantly in these structures is the strength of the SO interaction.

Let us consider the results of measurement of SdH oscillations obtained for the structure Z76 with $In_{0.2}Ga_{0.8}As$ QW. The gate voltage dependences of the electron density, plotted in the inset in Fig. 13 shows that, just as in the GaAs structure, the electron density found from the Hall effect and the SdH oscillations coincide and depend linearly on V_q .

The N dependences of the oscillation phases of $\delta \rho_{xx}$ and δR_H for the structure Z76 shown in Fig. 14(a) practically coincide with those for the structure T1520 (Fig. 6).

$V_g(V)$	$n(\mathrm{cm}^{-2})$	$\mu \ (m^2/Vs)$	m/m_0	$\Delta_L \ ({\rm meV})$	$ au/ au_q$	
structure T1520						
-2.5	9.40×10^{11}	0.89		3.20	3.54	
-1.0	1.30×10^{12}	1.50	0.067	2.76	5.06	
-0.25	1.46×10^{12}	1.83		2.56	5.6	
structure Z76						
-0.70	$(5.16 \pm 0.02) \times 10^{11}$	2.45 ± 0.02		1.90 ± 0.05	5.42	
-0.45	5.48×10^{11}	2.56	0.06 ± 0.005	1.64	4.96	
-0.20	5.90×10^{11}	2.78		1.25	4.15	

^a For $V_g = 0$ V



FIG. 13. (color online) Oscillating parts $\delta \rho_{xx}(B)$ and $\delta R_H(B)$ in the structure Z76 with $\text{In}_{0.2}\text{Ga}_{0.8}\text{As}$ QW for two electron densities $n = 5.16 \times 10^{11} \text{ cm}^{-2}$ (a) and $5.91 \times 10^{11} \text{ cm}^{-2}$ (b). The inset in panel (a) shows the gate voltage dependence of electron density found from the Hall effect (circles) and from SdH oscillations (crosses). The line in the inset is the dependence $n = (6.25 + 1.6 V_g) \times 10^{11} \text{ cm}^{-2}$. T = 1.7 K.

As for the N dependences of the ratio of the oscillation amplitudes, they are qualitatively similar, but as Fig. 14(b) shows R(N) for the structure Z76 exhibits much stronger increase of R with decreasing N. A very similar behaviour of R(N) is observed for the structure 170938 with HgTe QW of 5.1 nm width [see Fig. 9].

All the above results make us think that the difference in the behaviour of R(N) is a consequence of a strong difference of strength of SO interaction. As discussed above, the amplitudes of the ρ_{xx} and R_H oscillations are determined by the oscillations of the density of states, and as long as the spin-orbit splitting remains less than the broadening of the Landau levels, the SO interaction should not change the ratio of the amplitudes of the ρ_{xx} and R_H oscillations.

One can assume that the SO interaction with a scatterer potential changes the scattering in such a way that leads to the observed behaviour of R(N).



FIG. 14. (color online) (a) Dependences of phases of oscillations of $\rho_{xx}(B)$ and $R_H(B)$ on N. (b) The R values plotted against the filling factor. The structure Z76 with In_{0.2}Ga_{0.8}As QW, T = 1.7 K. The balls in the panel (b) are the data for GaAs QW.

As far as we understand it is the SO interaction with the potential of scatterers that is the cause of the spin Hall effect.

We are aware of only one paper [19] which provides a phenomenological description of the spin Hall effect in a magnetic field. This consideration was made for the three-dimensional (3D) case. Nevertheless, ρ_{xx} and ρ_{xy} estimates made within this approach for the 2D case gives the N dependence of ratio R qualitatively similar to the experiment; its value increases with decreasing N. For a reliable conclusion that all the above results on difference in behavior R(N) and R(1/B) with the increasing HgTe-QW width requires more detailed theoretical calculations taking into account, among other things, the features of the spectrum of HgTe QW.

VII. CONCLUSION

In this paper, systematic experimental studies of the oscillations of ρ_{xx} , R_H and capacitance both for GaAs, and $\ln_x \operatorname{Ga}_{1-x} \operatorname{As}$ structures with a simple spectrum of the conduction band and HgTe structures with a non-parabolic complicated spectrum and strong spin-orbit interaction were carried out. The HgTe structures with normal and inverted spectra, d < 6.3 nm and d > 6.3 nm, respectively, were studied.

It has been found that the positions of the ρ_{xx} and C oscillations in a magnetic field coincide for all the structures under study. This indicates that the oscillations of ρ_{xx} is determined only by the oscillations of the density of states in the magnetic field.

For all the structures, the phase difference in the ρ_{xx} and R_H oscillations agrees with the theoretical value π only for large filling factors (N > 15) and increases at smaller N. Such behavior is consistent with the results of Ref. [8], in which it is assumed that the phase difference at N < 15 is due to approaching the QHE regime. However, our measurements performed for different temperatures shows that this is not the case. So, the physical reason for the difference between experiment and theory remains unclear.

The most surprising result relates to the ratio of the amplitudes of the ρ_{xx} and R_H oscillations A_{ρ}/A_H . In the structure with GaAs QW with a simple spectrum and a negligible Zeeman and spin-orbit splitting, the ratio of the amplitudes A_{ρ}/A_H is close to the theoretical $-2\mu^2 B^2$ (but also at N > 15). In contrast, in structures with HgTe QW, this ratio differs from theoretical predictions and differently in structures with a normal spectrum, it tends to the theoretical value with the growth of N. In structures with an inverted spectrum, it remains different from the theoretical one for all available N and does not tend to the theoretical one with increasing N.

It is assumed that such a difference in the ratio of amplitudes A_{ρ}/A_H relates not to the features of the energy spectrum of HgTe QW, but to the features of electron scattering due to SO interaction with the potential of the scatterers.

To elucidate the role of this mechanism, all the same measurements were carried out for the structure with In_{0.2}Ga_{0.8}As, which spectrum is very close to that of GaAs QW, but differs only by a significantly stronger spin-orbit interaction. This is evidenced by measurements of weak antilocalization magnetoresistivity. Its analysis allows us to determine the value of spin-orbit splitting as (0.1 - 0.15) meV, which is significantly less than the broadening of the Landau levels $\Delta_L \simeq 1.9$ meV. The positions of the ρ_{xx} and C oscillations, the phase difference of ρ_{xx} and R_H and its dependence on the filling factor in this structure are close to those observed in GaAs QW. But the ratio of the oscillation amplitudes A_{ρ}/A_H differs strongly. It and its N dependence become close to that observed in HgTe QW with normal spectrum.

Thus, we believe that the change in scattering due to the SO interaction with the potential of the scatterers is the reason for the difference in the ratio of the amplitudes A_{ρ}/A_{H} in the HgTe quantum well. Such a change in scattering due to SO interaction with the potential of the scatterers is one of the reasons for the spin-Hall effect. There are many papers on the spin-Hall effect in the absence of a magnetic field [20]. We know only one paper [19] in which the phenomenological model of the spin-Hall effect in a magnetic field is considered for 3D systems. Estimates for 2D systems performed along this line of attack give qualitative agreement with experimental results. For a reliable conclusion that all of the above leads to a difference in the behaviour of R(N)and R(1/B) with an increase in the width of HgTe QW, more detailed theoretical calculations are required, taking into account, among other things, the features of the QW spectrum.

If the peculiarity in the behaviour of the ratio of the amplitudes of the ρ_{xx} and R_H oscillations in the magnetic field is indeed related to the spin-orbit interaction with the potential of the scatterers, then this would give a purely electrical method for measuring the spin-Hall effect.

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- I. M. Lifshits and A. M. Kosevich, Theory of magnetic susceptibility in metals at low temperatures, Zh. Eksp. Teor. Fiz. **29**, 730 (1955), [Sov. Phys. JETP **2**, 636 (1956)].
- [2] T. Ando, Theory of quantum transport in a twodimensional electron system under magnetic fields. iv. oscillatory conductivity, J. Phys. Soc. Japan 37, 1233 (1974).
- [3] T. Ando, T. Matsumoto, and Y. Uemura, J. Phys. Soc. Japan 39, 279 (1975).
- [4] A. A. Isihara and L. Smrěcka, J. Phys. C: Solid State Phys 19, 6777 (1986).
- [5] S. Novokshonov, Magneto-intersubband oscillations of the kinetic coefficients of twodimensional system with a spin-orbit interaction, Low Temperature Physics **39** (2013).

- [6] I. A. Dmitriev, A. D. Mirlin, D. G. Polyakov, and M. A. Zudov, Nonequilibrium phenomena in high landau levels, Rev. Mod. Phys. 84, 1709 (2012).
- [7] As seen from Eq. (8), the magnetic field of the Nth ρ_{xx} minimum (B_N) corresponds to the minimum of the density of states at the Fermi level, when the integer number of Landau levels are occupied, i.e., the Fermi level is located between the two Landau levels. Note, the values of B_N are different for the two regimes: $E_F = \text{const}_B$ and $n = \text{const}_B$. In the first case, taking into account the fact that the energy of the Landau levels is $E_N = \hbar \omega_c (N + 1/2 + \phi)$, where ϕ is the Berry phase, the fields of ρ_{xx} minima are determined by the condition $\varepsilon_F = E_N + \hbar \omega_c/2 = e\hbar B_N/m \times (N+1/2+1/2+\phi)$. Thus we get $B_N = \varepsilon_F / [e\hbar/m(N+1+\phi)]$, i.e., an extrapolation of the N versus $1/B_N$ experimental plot allows us to obtain the Barry phase. In the second case, $n = \text{const}_B$, the condition for filling an integer number of Landau levels is simpler: the number of states at twofold degenerate Landau levels in the field B is $eB/(\pi\hbar)$, so $B_N = \pi\hbar n/(eN)$, This shows that at $n = \text{const}_B B_N$ does not include the Berry phase [21].
- [8] P. T. Coleridge, R. Stoner, and R. Fletcher, Low-field transport coefficients in gaas/ga_{1-x}al_xas heterostructures, Phys. Rev. B **39**, 1120 (1989).
- [9] N. N. Mikhailov, R. N. Smirnov, S. A. Dvoretsky, Y. G. Sidorov, V. A. Shvets, E. V. Spesivtsev, and S. V. Rykhlitski, Growth of hgcdte nanostructures by molecular beam epitaxy with ellipsometric control, Int. J. Nanotechnology 3, 120 (2006).
- [10] In the equations given in Section I, only the short-range potential scattering is taken into account, so there are no monotonous parts of the dependences $\rho_{xx}(B)$, $R_H(B)$. In real structures, there are various mechanisms that can lead to their appearance, for instance, the scattering by potential fluctuations, the electron-electron interaction, etc.
- [11] As shown in numerous papers (see, e.g., [22–27] and references therein) different types of spectrum are realized depending on the QW width. When QW is narrow, $d < d_c$, the ordering of energy subbands of spatial quantization is analogous to that in conventional semiconductors; the highest valence subband at k = 0 is formed from the heavy hole Γ_8 states, while the lowest conduction subband is formed both from the Γ_6 states and light hole Γ_8 states. For a thicker HgTe layer, $d > d_c$, the quantum well is in the inverted regime; the lowest conduction subband is formed from the heavy hole Γ_8 states [28], whereas the subband formed from the Γ_6 states and light hole Γ_8 states sinks into the valence band. In the inverted regime, the spectrum becomes semimetallic at $d \gtrsim 15$ nm due to overlapping of the valence and conduction bands.
- [12] G. M. Minkov, O. E. Rut, A. A. Sherstobitov, S. A. Dvoretski, N. N. Mikhailov, V. A. Solov'ev, M. Y. Chernov, S. V. Ivanov, and A. V. Germanenko, Magneto-intersubband oscillations in two-dimensional systems with an energy spectrum split due to spin-orbit interaction, Phys. Rev. B 101, 245303 (2020).
- [13] G. M. Minkov, V. Y. Aleshkin, O. E. Rut, A. A. Sherstobitov, S. A. Dvoretski, N. N. Mikhailov, and A. V. Germanenko, Transformation of energy spectrum and wave functions on the way from a 2dto-3d topological insulator in hgte quantum wells, Phys. Rev. B 106, 085301 (2022).

- [14] S. H. Simon and B. I. Halperin, Explanation for the resistivity law in quantum hall systems, Phys. Rev. Lett. 73, 3278 (1994).
- [15] R. G. Mani, W. B. Johnson, V. Umansky, V. Narayanamurti, and K. Ploog, Phase study of oscillatory resistances in microwave-irradiated- and dark-gaas/algaas devices: Indications of an unfamiliar class of the integral quantum hall effect, Phys. Rev. B **79**, 205320 (2009).
- [16] Q. Qian, J. Nakamura, S. Fallahi, G. C. Gardner, J. D. Watson, S. Lüscher, J. A. Folk, G. A. Csáthy, and M. J. Manfra, Quantum lifetime in ultrahigh quality gaas quantum wells: Relationship to $\Delta_{5/2}$ and impact of density fluctuations, Phys. Rev. B **96**, 035309 (2017).
- [17] The inverted character of the spectrum in this structure is justified in our article [29], in which the intersection of Landau levels belonging to the conduction and valence bands, specific for quantum wells with an inverted spectrum, was observed.
- [18] G. M. Minkov, A. A. Sherstobitov, A. V. Germanenko, O. E. Rut, V. A. Larionova, and B. N. Zvonkov., Antilocalization and spin-orbit coupling in hole strained gaas/in_xga_{1-x}as/gaas quantum well heterostructures, Phys. Rev. B **71**, 165312 (1 (2005).
- [19] M. I. Dyakonov and A. V. Khaetskii, Spin hall effect, in *Spin Physics in Semiconductors*, edited by M. I. Dyakonov (Springer Berlin Heidelberg, Berlin, Heidelberg, 2008) pp. 211–243.
- [20] J. Sinova, S. O. Valenzuela, J. Wunderlich, C. H. Back, and T. Jungwirth, Spin hall effects, Rev. Mod. Phys. 87, 1213 (2015).
- [21] A. Y. Kuntsevich, A. V. Shupletsov, and G. M. Minkov, Simple mechanisms that impede the berry phase identification from magneto-oscillations, Phys. Rev. B 97, 195431 (2018).
- [22] L. G. Gerchikov and A. Subashiev, Interface states in subbabnd structure of semiconductor quantum well, Phys. Stat. Sol. (b) 160, 443 (1990).
- [23] X. C. Zhang, A. Pfeuffer-Jeschke, K. Ortner, V. Hock, H. Buhmann, C. R. Becker, and G. Landwehr, Rashba splitting in *n* -type modulation-doped hgte quantum wells with an inverted band structure, Phys. Rev. B 63, 245305 (2001).
- [24] E. G. Novik, A. Pfeuffer-Jeschke, T. Jungwirth, V. Latussek, C. R. Becker, G. Landwehr, H. Buhmann, and L. W. Molenkamp, Band structure of semimagnetic $hg_{1-y}mn_y$ te quantum wells, Phys. Rev. B **72**, 035321 (2005).
- [25] B. A. Bernevig, T. L. Hughes, and S.-C. Zhang, Quantum spin hall effect and topological phase transition in hgte quantum wells, Science **314**, 1757 (2006).
- [26] M. Zholudev, Ph.D. thesis, University Montpellier 2, France (2013).
- [27] Y. Ren, Z. Qiao, and Q. Niu, Topological phases in two-dimensional materials: a review, Reports on Progress in Physics **79**, 066501 (2016).
- [28] M. I. D'yakonov and A. Khaetskii, Zh. Eksp. Teor. Fiz. 82, 1584 (1982), [Sov. Phys. JETP 55, 917 (1982)].
- [29] G. M. Minkov, A. V. Germanenko, O. E. Rut, A. A. Sherstobitov, M. O. Nestoklon, S. A. Dvoretski, and N. N. Mikhailov, Spin-orbit splitting of valence and conduction bands in hgte quantum wells near the dirac point, Phys. Rev. B **93**, 155304 (2016).